2.5 A Fully Integrated Li-Ion Switching Battery Charger with Power Path Management and USB On-The-Go Support

The NCP1854 is a fully programmable single cell Lithium-ion switching battery charger optimized for charging from a USB compliant input supply and AC adaptor power source. The device integrates a synchronous PWM controller, power MOSFETs, and the entire charge cycle monitoring including safety features under software supervision. An optional battery FET can be placed between the system and the battery in order to isolate and supply the system. The NCP1854 junction temperature is monitored during charge cycle and both current and voltage can be modified accordingly through I²C setting. The charger activity and status are reported through a dedicated pin to the system. The input pin is protected against overvoltages.

The NCP1854 also provides USB OTG support by boosting the battery voltage as well as providing overvoltage protected power supply for USB transceiver.

Features

- 2.5 A Buck Converter with Integrated Pass Devices
- Input Current Limiting to Comply to USB Standard
- Automatic Charge Current for AC Adaptor Charging
- High Accuracy Voltage and Current Regulation
- Input Overvoltage Protection up to +28 V
- Factory Mode
- 1000 mA Boosted Supply for USB OTG Peripherals
- Reverse Leakage Protection Prevents Battery Discharge
- Protected USB Transceiver Supply Switch
- Dynamic Power Path with Optional Battery FET
- Silicon Temperature Supervision for Optimized Charge Cycle
- Safety Timers
- Flag Output for Charge Status and Interrupts
- I²C Control Bus up to 3.4 MHz
- Small Footprint 2.2 x 2.55 mm CSP Package
- These Devices are Pb-Free and are RoHS Compliant

Typical Applications

- Smart Phone
- Handheld Devices
- Tablets
- PDAs



ON Semiconductor®

http://onsemi.com



25 BUMP FLIP-CHIP CASE 499BN

MARKING DIAGRAM

1854 AYWW

1854 = Specific Device Code

A = Assembly Location

Y = Year

WW = Work Week

■ = Pb-Free Package

ORDERING INFORMATION

See detailed ordering and shipping information in the package dimensions section on page 24 of this data sheet.

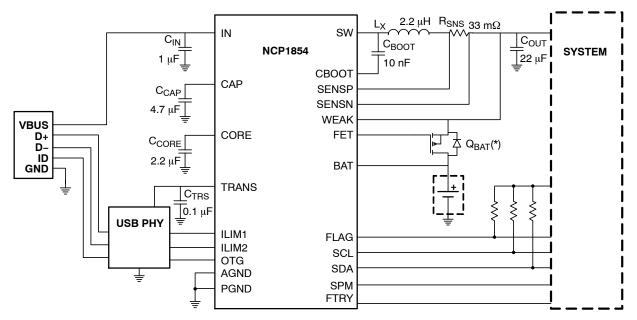


Figure 1. Typical Application Circuit

PIN CONNECTIONS

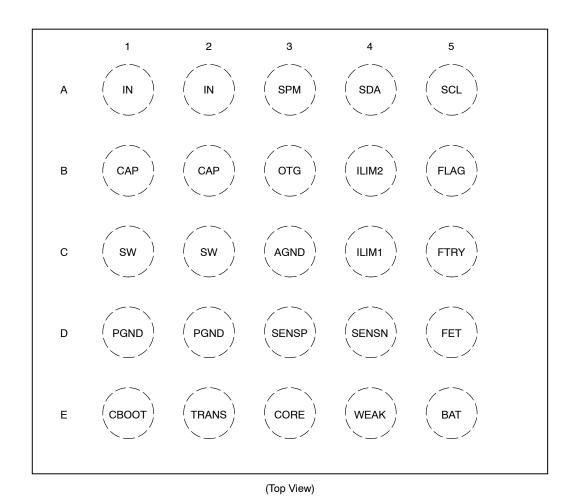


Figure 2. Package Outline CSP

Table 1. PIN FUNCTION DESCRIPTION

A1 IN POWER Battery Charger Input. These two pins must be decoupled by at least 1 μF capacitor and connected together. A2 IN POWER connected together. A3 SPM DIGITAL INPUT PSC data line BIDIRECTIONAL PC clock line A5 SCL DIGITAL INPUT PC clock line B1 CAP POWER CAP pin is the intermediate power supply input for all internal circuitry. Bypass with at least 4.7 μF capacitor. Must be tied together. B2 CAP POWER CAP pin is the intermediate power supply input for all internal circuitry. Bypass with at least 4.7 μF capacitor. Must be tied together. B3 OTG DIGITAL INPUT Enables OTG boost mode. OTG = 0, the boost is powered OFF OTG = 1 turns boost converter ON B4 ILIM2 DIGITAL INPUT Automatic charge current / input current limiter level selection (can be defeated by I²C). C1 SW ANALOG OUTPUT Connection from power MOSFET to the Inductor. C2 SW ANALOG OUTPUT Connection from power MOSFET to the Inductor. C3 AGND ANALOG GROUND Analog ground / reference. This pin should be connected to the ground plane and must be connected together. </th <th>Pin</th> <th>Name</th> <th>Туре</th> <th colspan="3">Description</th>	Pin	Name	Туре	Description			
A3 SPM DIGITAL INPUT System Power Monitor input. A5 SCL DIGITAL INPUT I ² C clock line B1 CAP POWER CAP pin is the intermediate power supply input for all internal circuitry. Bypass with at least 4.7 μF capacitor. Must be tied together. B3 OTG DIGITAL INPUT Enables OTG boost mode. OTG = 0, the boost is powered OFF OTG = 1 turns boost converter ON B4 ILIM2 DIGITAL INPUT Automatic charge current / Input current limiter level selection (can be defeated by I ² C). B5 FLAG OPEN DRAIN OUTPUT Connection from power MOSFET to the Inductor. C1 SW ANALOG OUTPUT Connection from power MOSFET to the Inductor. C2 SW ANALOG OUTPUT Connection from power MOSFET to the Inductor. C3 AGND ANALOG GROUND Analog ground / reference. This pin should be connected to the ground plane and must be connected together. C4 ILIM1 DIGITAL INPUT Input current limiter level selection (can be defeated by I ² C). C5 FTRY DIGITAL INPUT Input current limiter level selection (can be defeated by I ² C). C6 FTRY DIGITAL INPUT Input current limiter level selection (can be defeated by I ² C). C7 Factory mode pin. Refer to section "Factory mode and no battery operation". Internally pulled up to CORE pin. D6 PGND POWER GND Power ground. These pins should be connected to the ground plane and must be connected together. D7 PGND POWER GND Power ground. These pins should be connected to the ground plane and must be connected together. D8 SENSN ANALOG INPUT Current sense input. This pin is the positive current sense input. It should be connected to the R _{SENSE} resistor positive terminal. D8 SENSN ANALOG INPUT Current sense input. This pin is the positive current sense input. It should be connected to the R _{SENSE} resistor positive terminal. E6 TRANS ANALOG OUTPUT Stating Bootstrap connection. A 10 nF capacitor must be connected between CBOOT and SW. E7 TRANS ANALOG OUTPUT Stating Bootstrap connection. A 10 nF capacitor must be connected between CBOOT and SW. E8 CORE ANALOG	A1	IN	POWER				
A5 SCL DIGITAL INPUT I ² C clock line B1 CAP POWER CAP pin is the intermediate power supply input for all internal circuitry. Bypass with at least 4.7 μF capacitor. Must be tied together. B3 OTG DIGITAL INPUT Enables OTG boost mode. OTG = 0, the boost is powered OFF OTG = 1 turns boost converter ON B4 ILIM2 DIGITAL INPUT Automatic charge current / input current limiter level selection (can be defeated by I ² C). B5 FLAG OPEN DRAIN OUTPUT C1 SW ANALOG OUTPUT C2 SW ANALOG OUTPUT C3 AGND ANALOG GROUND Analog ground / reference. This pin should be connected to the ground plane and must be connected together. C4 ILIM1 DIGITAL INPUT Input current limiter level selection (can be defeated by I ² C). C5 FTRY DIGITAL INPUT Analog ground / reference. This pin should be connected to the ground plane and must be connected together. C5 FTRY DIGITAL INPUT Factory mode pin. Refer to section "Factory mode and no battery operation". Internally pulled up to CORE pin. D1 PGND POWER GND POWER GND POWER GND POWER GND POWER GND FOWER GND POWER GND ANALOG INPUT Current sense input. This pin is the positive current sense input. It should be connected to the R _{SENSE} resistor positive terminal. D5 FET ANALOG INPUT Current sense input. This pin is the negative current sense input. It should be connected to the R _{SENSE} resistor positive terminal. E6 CRE ANALOG OUTPUT Battery FET driver output. When not used, this pin must be directly tied to ground. E7 FTRY ANALOG OUTPUT Battery FET driver output. When not used, this pin must be directly tied to ground. E7 FTRY ANALOG OUTPUT States provided be provided be provided by the positive current sense input. It should be connected to the R _{SENSE} resistor positive terminal. E8 FTRY ANALOG OUTPUT States provided provided provided by the provided provided by the provided provided by the provided provided by the provided provided provided provided and will never be higher than 5.5 V.	A2	IN	POWER	connected together.			
BIDIRECTIONAL AS SCL DIGITAL INPUT IPC clock line CAP POWER B1 CAP POWER B2 CAP POWER B3 OTG DIGITAL INPUT Enables OTG boost mode. OTG = 0, the boost is powered OFF OTG = 1 turns boost converter ON OTF = 1 turns boost converter on the turns boost converter to turn be defeated by IPC). OTF = 1 turns boost converter to turns tu	A3	SPM	DIGITAL INPUT	System Power Monitor input.			
B1 CAP POWER CAP pin is the intermediate power supply input for all internal circuitry. Bypass with at least 4.7 μF capacitor. Must be tied together.	A4	SDA		I ² C data line			
B2 CAP POWER least 4.7 μF capacitor. Must be tied together.	A5	SCL	DIGITAL INPUT	I ² C clock line			
B3 OTG DIGITAL INPUT Enables OTG boost mode. OTG = 0, the boost is powered OFF OTG = 1 turns boost converter ON B4 ILIM2 DIGITAL INPUT Automatic charge current / Input current limiter level selection (can be defeated by I ² C). B5 FLAG OPEN DRAIN OUTPUT Charging state active low. This is an open drain pin that can either drive a status LED or connect to interrupt pin of the system. C1 SW ANALOG OUTPUT Connection from power MOSFET to the Inductor. These pins must be connected together. C3 AGND ANALOG GROUND Analog ground / reference. This pin should be connected to the ground plane and must be connected together. C4 ILIM1 DIGITAL INPUT Input current limiter level selection (can be defeated by I ² C). C5 FTRY DIGITAL INPUT Factory mode pin. Refer to section "Factory mode and no battery operation". Internally pulled up to CORE pin. D1 PGND POWER GND Power ground. These pins should be connected to the ground plane and must be connected together. D3 SENSP ANALOG INPUT Current sense input. This pin is the positive current sense input. It should be connected to the R _{SENSE} resistor positive terminal. D4 SENSN ANALOG INPUT Current sense input. This pin is the negative current sense input. It should be connected to the R _{SENSE} resistor negative terminal. D4 SENSN ANALOG OUTPUT Battery FET driver output. When not used, this pin must be directly tied to ground. E1 CBOOT ANALOG IN/OUT Floating Bootstrap connection. A 10 nF capacitor must be connected between CBOOT and SW. E2 TRANS ANALOG OUTPUT Store output. When not used, this pin must be directly tied to ground. E3 CORE ANALOG OUTPUT Store output. When not used, this pin must be directly tied to ground. E4 CBOOT ANALOG OUTPUT Floating Bootstrap connection. A 10 nF capacitor must be connected between CBOOT and SW. E5 TRANS ANALOG OUTPUT Store output. When not used, this pin insolud be bypassed by a 100 nF ceramic capacitor. E5 CORE ANALOG OUTPUT 5 V reference voltage of the IC. This pin should be bypassed by a 100 nF ceramic capacitor.	B1	CAP	POWER				
DTG = 0, the boost is powered OFF OTG = 1 turns boost converter ON B4 ILIM2 DIGITAL INPUT Automatic charge current / Input current limiter level selection (can be defeated by I²C). B5 FLAG OPEN DRAIN OUTPUT Connect to interrupt pin of the system. C1 SW ANALOG OUTPUT CONNECTION OUTPUT COURT ON OUTPUT CONNECTION OUTPUT CONNECTION OUTPUT CONNECTION OUTPUT COURT OUTPUT CONNECTION OUTPUT CONNECTION OUTPUT CONNECTION OUTPUT CONNECTION OUTPUT CONNECTION OUTPUT COURT OUTPUT COUNT OUTPUT COUN	B2	CAP	POWER	least 4.7 με capacitor. Must be tied together.			
FLAG OPEN DRAIN OUTPUT Charging state active low. This is an open drain pin that can either drive a status LED or connect to interrupt pin of the system. C1	В3	OTG	DIGITAL INPUT	OTG = 0, the boost is powered OFF			
C1 SW ANALOG OUTPUT Connect to interrupt pin of the system. C2 SW ANALOG OUTPUT These pins must be connected together. C3 AGND ANALOG GROUND Analog ground / reference. This pin should be connected to the ground plane and must be connected together. C4 ILIM1 DIGITAL INPUT Input current limiter level selection (can be defeated by I ² C). C5 FTRY DIGITAL INPUT Factory mode pin. Refer to section "Factory mode and no battery operation". Internally pulled up to CORE pin. D1 PGND POWER GND Power ground. These pins should be connected to the ground plane and must be connected together. D3 SENSP ANALOG INPUT Current sense input. This pin is the positive current sense input. It should be connected to the R _{SENSE} resistor positive terminal. D4 SENSN ANALOG INPUT Current sense input. This pin is the negative current sense input. It should be connected to the R _{SENSE} resistor negative terminal. This pin is also voltage sense input of the voltage regulation loop when the FET is present and open. D5 FET ANALOG OUTPUT Battery FET driver output. When not used, this pin must be directly tied to ground. E1 CBOOT ANALOG IN/OUT Floating Bootstrap connection. A 10 nF capacitor must be connected between CBOOT and SW. E2 TRANS ANALOG OUTPUT Output supply to USB transceiver. This pin can source a maximum of 50 mA to the external USB PHY or any other IC that needs +5 V USB. This pin is Overvoltage protected and will never be higher than 5.5 V. This pin should be bypassed by a 100 nF ceramic capacitor. E3 CORE ANALOG OUTPUT 5 V reference voltage of the IC. This pin should be bypassed by a 2.2 μF capacitor. No load must be connected to this pin.	B4	ILIM2	DIGITAL INPUT	Automatic charge current / Input current limiter level selection (can be defeated by I ² C).			
These pins must be connected together. C2 SW ANALOG OUTPUT Analog ground / reference. This pin should be connected to the ground plane and must be connected together. C4 ILIM1 DIGITAL INPUT Input current limiter level selection (can be defeated by I²C). C5 FTRY DIGITAL INPUT Factory mode pin. Refer to section "Factory mode and no battery operation". Internally pulled up to CORE pin. D1 PGND POWER GND Power ground. These pins should be connected to the ground plane and must be connected together. D3 SENSP ANALOG INPUT Current sense input. This pin is the positive current sense input. It should be connected to the R _{SENSE} resistor positive terminal. D4 SENSN ANALOG INPUT Current sense input. This pin is the negative current sense input. It should be connected to the H _{SENSE} resistor negative terminal. This pin is also voltage sense input of the voltage regulation loop when the FET is present and open. D5 FET ANALOG OUTPUT Battery FET driver output. When not used, this pin must be directly tied to ground. E1 CBOOT ANALOG IN/OUT Floating Bootstrap connection. A 10 nF capacitor must be connected between CBOOT and SW. E2 TRANS ANALOG OUTPUT Output supply to USB transceiver. This pin can source a maximum of 50 mA to the external USB PHY or any other IC that needs +5 V USB. This pin is Overvoltage protected and will never be higher than 5.5 V. This pin should be bypassed by a 1.00 nF ceramic capacitor. E3 CORE ANALOG OUTPUT 5 V reference voltage of the IC. This pin should be bypassed by a 2.2 μF capacitor. No load must be connected to this pin.	B5	FLAG					
C2 SW ANALOG OUTPUT C3 AGND ANALOG GROUND Analog ground / reference. This pin should be connected to the ground plane and must be connected together. C4 ILIM1 DIGITAL INPUT Input current limiter level selection (can be defeated by I ² C). C5 FTRY DIGITAL INPUT Factory mode pin. Refer to section "Factory mode and no battery operation". Internally pulled up to CORE pin. D1 PGND POWER GND Power ground. These pins should be connected to the ground plane and must be connected together. D2 PGND POWER GND D3 SENSP ANALOG INPUT Current sense input. This pin is the positive current sense input. It should be connected to the R _{SENSE} resistor positive terminal. Current sense input. This pin is the negative current sense input. It should be connected to the R _{SENSE} resistor negative terminal. This pin is also voltage sense input of the voltage regulation loop when the FET is present and open. D5 FET ANALOG OUTPUT Battery FET driver output. When not used, this pin must be directly tied to ground. E1 CBOOT ANALOG IN/OUT Floating Bootstrap connection. A 10 nF capacitor must be connected between CBOOT and SW. E2 TRANS ANALOG OUTPUT Output supply to USB transceiver. This pin can source a maximum of 50 mA to the external USB PHY or any other IC that needs +5 V USB. This pin is Overvoltage protected and will never be higher than 5.5 V. This pin should be bypassed by a 100 nF ceramic capacitor. E3 CORE ANALOG OUTPUT 5 V reference voltage of the IC. This pin should be bypassed by a 2.2 μF capacitor. No load must be connected to this pin.	C1	SW	ANALOG OUTPUT				
be connected together. C4 ILIM1 DIGITAL INPUT Input current limiter level selection (can be defeated by I²C). C5 FTRY DIGITAL INPUT Factory mode pin. Refer to section "Factory mode and no battery operation". Internally pulled up to CORE pin. D1 PGND POWER GND Power ground. These pins should be connected to the ground plane and must be connected together. D3 SENSP ANALOG INPUT Current sense input. This pin is the positive current sense input. It should be connected to the R _{SENSE} resistor positive terminal. D4 SENSN ANALOG INPUT Current sense input. This pin is the negative current sense input. It should be connected to the R _{SENSE} resistor negative terminal. This pin is also voltage sense input of the voltage regulation loop when the FET is present and open. D5 FET ANALOG OUTPUT Battery FET driver output. When not used, this pin must be directly tied to ground. E1 CBOOT ANALOG IN/OUT Floating Bootstrap connection. A 10 nF capacitor must be connected between CBOOT and SW. E2 TRANS ANALOG OUTPUT Output supply to USB transceiver. This pin can source a maximum of 50 mA to the external USB PHY or any other IC that needs +5 V USB. This pin is Overvoltage protected and will never be higher than 5.5 V. This pin should be bypassed by a 100 nF ceramic capacitor. E3 CORE ANALOG OUTPUT 5 V reference voltage of the IC. This pin should be bypassed by a 2.2 μF capacitor. No load must be connected to this pin.	C2	SW	ANALOG OUTPUT	I nese pins must be connected together.			
C5 FTRY DIGITAL INPUT Factory mode pin. Refer to section "Factory mode and no battery operation". Internally pulled up to CORE pin. D1 PGND POWER GND Power ground. These pins should be connected to the ground plane and must be connected together. D2 PGND POWER GND Current sense input. This pin is the positive current sense input. It should be connected to the R _{SENSE} resistor positive terminal. D4 SENSN ANALOG INPUT Current sense input. This pin is the negative current sense input. It should be connected to the R _{SENSE} resistor positive terminal. This pin is also voltage sense input of the voltage regulation loop when the FET is present and open. D5 FET ANALOG OUTPUT Battery FET driver output. When not used, this pin must be directly tied to ground. E1 CBOOT ANALOG IN/OUT Floating Bootstrap connection. A 10 nF capacitor must be connected between CBOOT and SW. D4 Output supply to USB transceiver. This pin can source a maximum of 50 mA to the external USB PHY or any other IC that needs +5 V USB. This pin is Overvoltage protected and will never be higher than 5.5 V. This pin should be bypassed by a 100 nF ceramic capacitor. E3 CORE ANALOG OUTPUT 5 V reference voltage of the IC. This pin should be bypassed by a 2.2 μF capacitor. No load must be connected to this pin.	C3	AGND	ANALOG GROUND				
D1 PGND POWER GND Power ground. These pins should be connected to the ground plane and must be connected together. D2 PGND POWER GND POWER GND D3 SENSP ANALOG INPUT Current sense input. This pin is the positive current sense input. It should be connected to the R _{SENSE} resistor positive terminal. D4 SENSN ANALOG INPUT Current sense input. This pin is the negative current sense input. It should be connected to the R _{SENSE} resistor negative terminal. This pin is also voltage sense input of the voltage regulation loop when the FET is present and open. D5 FET ANALOG OUTPUT Battery FET driver output. When not used, this pin must be directly tied to ground. E1 CBOOT ANALOG IN/OUT Floating Bootstrap connection. A 10 nF capacitor must be connected between CBOOT and SW. E2 TRANS ANALOG OUTPUT Output supply to USB transceiver. This pin can source a maximum of 50 mA to the external USB PHY or any other IC that needs +5 V USB. This pin is Overvoltage protected and will never be higher than 5.5 V. This pin should be bypassed by a 100 nF ceramic capacitor. E3 CORE ANALOG OUTPUT 5 V reference voltage of the IC. This pin should be bypassed by a 2.2 μF capacitor. No load must be connected to this pin.	C4	ILIM1	DIGITAL INPUT	Input current limiter level selection (can be defeated by I ² C).			
D2 PGND POWER GND connected together. D3 SENSP ANALOG INPUT Current sense input. This pin is the positive current sense input. It should be connected to the R _{SENSE} resistor positive terminal. D4 SENSN ANALOG INPUT Current sense input. This pin is the negative current sense input. It should be connected to the R _{SENSE} resistor negative terminal. This pin is also voltage sense input of the voltage regulation loop when the FET is present and open. D5 FET ANALOG OUTPUT Battery FET driver output. When not used, this pin must be directly tied to ground. E1 CBOOT ANALOG IN/OUT Floating Bootstrap connection. A 10 nF capacitor must be connected between CBOOT and SW. E2 TRANS ANALOG OUTPUT Output supply to USB transceiver. This pin can source a maximum of 50 mA to the external USB PHY or any other IC that needs +5 V USB. This pin is Overvoltage protected and will never be higher than 5.5 V. This pin should be bypassed by a 100 nF ceramic capacitor. E3 CORE ANALOG OUTPUT 5 V reference voltage of the IC. This pin should be bypassed by a 2.2 μF capacitor. No load must be connected to this pin.	C5	FTRY	DIGITAL INPUT				
D2 PGND POWER GND D3 SENSP ANALOG INPUT Current sense input. This pin is the positive current sense input. It should be connected to the R _{SENSE} resistor positive terminal. D4 SENSN ANALOG INPUT Current sense input. This pin is the negative current sense input. It should be connected to the R _{SENSE} resistor negative terminal. This pin is also voltage sense input of the voltage regulation loop when the FET is present and open. D5 FET ANALOG OUTPUT Battery FET driver output. When not used, this pin must be directly tied to ground. E1 CBOOT ANALOG IN/OUT Floating Bootstrap connection. A 10 nF capacitor must be connected between CBOOT and SW. E2 TRANS ANALOG OUTPUT Output supply to USB transceiver. This pin can source a maximum of 50 mA to the external USB PHY or any other IC that needs +5 V USB. This pin is Overvoltage protected and will never be higher than 5.5 V. This pin should be bypassed by a 100 nF ceramic capacitor. E3 CORE ANALOG OUTPUT 5 V reference voltage of the IC. This pin should be bypassed by a 2.2 μF capacitor. No load must be connected to this pin.	D1	PGND	POWER GND				
the R _{SENSE} resistor positive terminal. D4 SENSN ANALOG INPUT Current sense input. This pin is the negative current sense input. It should be connected to the R _{SENSE} resistor negative terminal. This pin is also voltage sense input of the voltage regulation loop when the FET is present and open. D5 FET ANALOG OUTPUT Battery FET driver output. When not used, this pin must be directly tied to ground. E1 CBOOT ANALOG IN/OUT Floating Bootstrap connection. A 10 nF capacitor must be connected between CBOOT and SW. E2 TRANS ANALOG OUTPUT Output supply to USB transceiver. This pin can source a maximum of 50 mA to the external USB PHY or any other IC that needs +5 V USB. This pin is Overvoltage protected and will never be higher than 5.5 V. This pin should be bypassed by a 100 nF ceramic capacitor. E3 CORE ANALOG OUTPUT 5 V reference voltage of the IC. This pin should be bypassed by a 2.2 μF capacitor. No load must be connected to this pin.	D2	PGND	POWER GND	connected together.			
to the R _{SENSE} resistor negative terminal. This pin is also voltage sense input of the voltage regulation loop when the FET is present and open. D5 FET ANALOG OUTPUT Battery FET driver output. When not used, this pin must be directly tied to ground. E1 CBOOT ANALOG IN/OUT Floating Bootstrap connection. A 10 nF capacitor must be connected between CBOOT and SW. E2 TRANS ANALOG OUTPUT Output supply to USB transceiver. This pin can source a maximum of 50 mA to the external USB PHY or any other IC that needs +5 V USB. This pin is Overvoltage protected and will never be higher than 5.5 V. This pin should be bypassed by a 100 nF ceramic capacitor. E3 CORE ANALOG OUTPUT 5 V reference voltage of the IC. This pin should be bypassed by a 2.2 μF capacitor. No load must be connected to this pin.	D3	SENSP	ANALOG INPUT	Current sense input. This pin is the positive current sense input. It should be connected to the R _{SENSE} resistor positive terminal.			
 E1 CBOOT ANALOG IN/OUT Floating Bootstrap connection. A 10 nF capacitor must be connected between CBOOT and SW. E2 TRANS ANALOG OUTPUT Output supply to USB transceiver. This pin can source a maximum of 50 mA to the external USB PHY or any other IC that needs +5 V USB. This pin is Overvoltage protected and will never be higher than 5.5 V. This pin should be bypassed by a 100 nF ceramic capacitor. E3 CORE ANALOG OUTPUT 5 V reference voltage of the IC. This pin should be bypassed by a 2.2 μF capacitor. No load must be connected to this pin. 	D4	SENSN	ANALOG INPUT	to the R _{SENSE} resistor negative terminal. This pin is also voltage sense input of the			
and SW. E2 TRANS ANALOG OUTPUT Output supply to USB transceiver. This pin can source a maximum of 50 mA to the external USB PHY or any other IC that needs +5 V USB. This pin is Overvoltage protected and will never be higher than 5.5 V. This pin should be bypassed by a 100 nF ceramic capacitor. E3 CORE ANALOG OUTPUT 5 V reference voltage of the IC. This pin should be bypassed by a 2.2 μF capacitor. No load must be connected to this pin.	D5	FET	ANALOG OUTPUT	Battery FET driver output. When not used, this pin must be directly tied to ground.			
external USB PHY or any other IC that needs +5 V USB. This pin is Overvoltage protected and will never be higher than 5.5 V. This pin should be bypassed by a 100 nF ceramic capacitor. E3 CORE ANALOG OUTPUT 5 V reference voltage of the IC. This pin should be bypassed by a 2.2 μF capacitor. No load must be connected to this pin.	E1	CBOOT	ANALOG IN/OUT				
No load must be connected to this pin.	E2	TRANS	ANALOG OUTPUT	external USB PHY or any other IC that needs +5 V USB. This pin is Overvoltage protected and will never be higher than 5.5 V. This pin should be bypassed by a 100 nF			
E4 WEAK ANALOG OUTPUT Weak battery charging current source input.	E3	CORE	ANALOG OUTPUT				
	E4	WEAK	ANALOG OUTPUT	Weak battery charging current source input.			
E5 BAT ANALOG INPUT Battery connection	E5	BAT	ANALOG INPUT	Battery connection			

Table 2. MAXIMUM RATINGS

Rating	Symbol	Value	Unit
IN (Note 1)	V _{IN}	-0.3 to +28	V
CAP (Note 1)	V _{CAP}	-0.3 to +28	V
Power balls: SW (Note 1)	V _{PWR}	-0.3 to +24	V
IN pin with respect to VCAP	V _{IN_CAP}	-0.3 to +7.0	V
CBOOT with respect to SW	V _{CBOOT_CAP}	-0.3 to +7.0	V
Sense/Control balls: SENSP, SENSN, VBAT, FET, TRANS, CORE, FLAG, INTB and WEAK. (Note 1)	V _{CTRL}	-0.3 to +7.0	V
Digital Input: SCL, SDA, SPM, OTG, ILIM, FTRY (Note 1) Input Voltage Input Current	V _{DG}	-0.3 to +7.0 V 20	V mA
Storage Temperature Range	T _{STG}	-65 to +150	°C
Maximum Junction Temperature (Note 4)	TJ	-40 to +TSD	°C
Moisture Sensitivity (Note 5)	MSL	Level 1	

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

Table 3. OPERATING CONDITIONS

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
V _{IN}	Operational Power Supply		3.6		V _{INOV}	V
V_{DG}	Digital input voltage level		0		5.5	V
T _A	Ambient Temperature Range		-40	25	+85	°C
I _{SINK}	FLAG sink current				10	mA
C _{IN}	Decoupling input capacitor			1		μF
C _{CAP}	Decoupling Switcher capacitor			4.7		μF
C _{CORE}	Decoupling core supply capacitor			2.2		μF
C _{OUT}	Decoupling system capacitor			22		μF
L _X	Switcher Inductor			2.2		μН
R _{SNS}	Current sense resistor			33		mΩ
$R_{\theta JA}$	Thermal Resistance Junction to Air	(Notes 4 and 6)		70		°C/W
TJ	Junction Temperature Range		-40	25	+125	°C

Functional operation above the stresses listed in the Recommended Operating Ranges is not implied. Extended exposure to stresses beyond the Recommended Operating Ranges limits may affect device reliability.

- With Respect to PGND. According to JEDEC standard JESD22-A108.
 This device series contains ESD protection and passes the following tests: Human Body Model (HBM) ±2.0 kV per JEDEC standard: JESD22-A114 for all pins. Machine Model (MM) ±200 V per JEDEC standard: JESD22-A115 for all pins.
- 3. Latch up Current Maximum Rating: ±100 mA or per ±10 mA JEDEC standard: JESD78 class II.
- 4. A thermal shutdown protection avoids irreversible damage on the device due to power dissipation. See Electrical Characteristics.
- A thermal strateown protection avoids in every size at the device due to power dissipation. See Electrical on a 5. Moisture Sensitivity Level (MSL): 1 per IPC/JEDEC standard: J–STD–020.
 The R_{θJA} is dependent on the PCB heat dissipation. Board used to drive this data was a 2s2p JEDEC PCB standard.

 $\begin{tabular}{ll} \textbf{Table 4. ELECTRICAL CHARACTERISTICS} \\ \begin{tabular}{ll} \textbf{Min \& Max Limits apply for T_A between -40°C to $+85^{\circ}$C and T_J up to $+125^{\circ}$C for V_{IN} between 3.9 V to 7 V (Unless otherwise noted).} \\ \begin{tabular}{ll} \textbf{Typical values are referenced to $T_A = +25^{\circ}$C and $V_{IN} = 5$ V (Unless otherwise noted).} \\ \end{tabular}$

Symbol	Parameter	Conditions		Min	Тур	Max	Unit
INPUT VOI	LTAGE			•			•
V _{INDET} Valid input detection threshold		V _{IN} rising		3.8	3.85	3.9	V
		V _{IN} falling		3.55	3.6	3.65	V
V _{BUSUV}	USB under voltage detection		V _{IN} falling	4.3	4.4	4.5	V
			Hysteresis	50	100	150	mV
V _{BUSOV}	USB over voltage detection		V _{IN} rising	5.55	5.65	5.75	V
50001			Hysteresis	25	75	125	mV
V _{INOV}	Valid input high threshold		V _{IN} rising	7.1	7.2	7.3	V
			Hysteresis	200	300	400	mV
INPUT CUI	I		.,,				
I _{INLIM}	Input current limit	V _{IN} = 5 V	Maximum Current range	100		2000	mA
IINLIIVI	'	IIV	Default value	70	85	100	mA
			Accuracy	-15		0	%
			from 500 mA to 2000 mA				,,
			I ² C Programmable granularity (From 500 mA to 2000 mA)		100		mA
INPUT SUF	PPLY CURRENT						
I _{Q_SW}	VBUS supply current	No load	d, Charger active state		15		mA
I _{OFF}	1 [С	harger not active		700		μΑ
CHARGER	DETECTION			•			
V _{CHGDET}	Charger detection threshold	V _{IN} -	- V _{SENSN} , V _{IN} rising	50	110	180	mV
	voltage	V _{IN} -	- V _{SENSN} , V _{IN} falling	15	30	50	mV
REVERSE	BLOCKING CURRENT						•
I _{LEAK}	V _{BAT} leakage current	Battery leaka	ge, V _{BAT} = 4.2 V, V _{IN} = 0 V, DA = SCL = 0 V		5		μΑ
R _{RBFET}	Input RBFET On resistance (Q1)		ve state, Measured between and CAP, V _{IN} = 5 V	-	45	75	mΩ
BATTERY	AND SYSTEM VOLTAGE REGULAT	ION					
V _{CHG}	Output voltage range	Pro	grammable by I ² C	3.3		4.5	V
			Default value		3.6		V
	Voltage regulation accuracy	Constant	voltage mode, T _A = 25°C	-0.5		0.5	%
				-1		1	%
	I ² C Programmable granularity				25		mV
BATTERY	VOLTAGE THRESHOLD			<u> </u>		1	
V _{SAFE}	Safe charge threshold voltage		V _{BAT} rising	2.1	2.15	2.2	V
V _{PRE}	Conditioning charge threshold voltage	V _{BAT} rising		2.75	2.8	2.85	V
V _{FET}	End of weak charge threshold	V _{BAT} rising	Voltage range	3.1		3.6	V
	voltage		Default value		3.4		
			Accuracy	-2		2	%
			I ² C Programmable granularity		100		mV
V _{RECHG}	Recharge threshold voltage	Relative to V _{CHG} setting register		Ì	97	1	%

 $\begin{tabular}{ll} \textbf{Table 4. ELECTRICAL CHARACTERISTICS} \\ \begin{tabular}{ll} \textbf{Min \& Max Limits apply for T_A between -40°C to $+85^{\circ}$C and T_J up to $+125^{\circ}$C for V_{IN} between 3.9 V to 7 V (Unless otherwise noted).} \\ \begin{tabular}{ll} \textbf{Typical values are referenced to $T_A = +25^{\circ}$C and $V_{IN} = 5$ V (Unless otherwise noted).} \\ \end{tabular}$

Symbol	Parameter	Conditions			Тур	Max	Unit
BATTERY V	VOLTAGE THRESHOLD						
V _{BUCKOV}	Overvoltage threshold voltage	V_{BAT} rising, relative to V_{CHG} setting register, measured on SENSN or SENSP, Q_{BAT} close or no Q_{BAT}			115		%
			Q _{BAT} open.		5		V
CHARGE C	CURRENT REGULATION						
I _{CHG}	Charge current range	Prog	grammable by I ² C	450		2500	mA
			Default value	950	1000	1050	mA
	Charge current accuracy			-50		50	mA
	I ² C Programmable granularity				100		mA
I _{PRE}	Pre-charge current		V _{BAT} < V _{PRE}	400	450	500	mA
I _{SAFE}	Safe charge current	,	V _{BAT} < V _{SAFE}	30	40	50	mA
I _{WEAK}	Weak battery charge current	BATFET present,	IWEAK[1:0] = 01	80	100	120	mA
		$V_{SAFE} < V_{BAT} < V_{FET}$	IWEAK[1:0] = 10	180	200	220	1
		YFEI	IWEAK[1:0] = 11	270	300	330	1
CHARGE T	ERMINATION	•					
I _{EOC}	Charge current termination	$V_{BAT} \ge V_{RECHG}$	Current range	100		275	mA
			Default value		150		1
			Accuracy, I _{EOC} < 200 mA	-25		25	1
			I ² C Programmable granularity		25		1
FLAG		•					<u> </u>
V _{FOL}	FLAG output low voltage	1	FLAG = 10 mA			0.5	V
I _{FLEAK}	Off-state leakage		V _{FLAG} = 5 V			1	μΑ
T _{FLGON}	Interrupt request pulse duration		Single event	150	200	250	μs
DIGITAL IN	IPUT (V _{DG})						
V _{IH}	High-level input voltage			1.2			V
V _{IL}	Low-level input voltage					0.4	V
R _{DG}	Pull up resistor (FRTY pin)				500		kΩ
	Pull down resistor (others pin)	1					
I _{DLEAK}	Input current		V _{DG} = 0 V	-0.5		0.5	μА
I ² C		•					
V _{SYSUV}	CAP pin supply voltage	I ² C registers available		2.5			V
V _I ² CINT	High level at SCL/SCA line			1.7		5	٧
V _I ² CIL	SCL, SDA low input voltage					0.4	٧
V _I ² CIH	SCL, SDA high input voltage			0.8* Vi ² CINT			V
V _I ² COL	SCL, SDA low output voltage	I _{SINK} = 3 mA				0.3	V
F _{SCL}	I ² C clock frequency					3.4	MHz

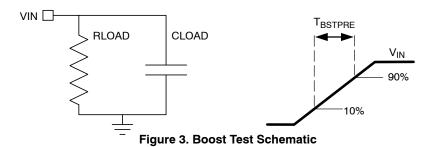
 $\begin{tabular}{ll} \textbf{Table 4. ELECTRICAL CHARACTERISTICS} \\ \begin{tabular}{ll} \textbf{Min \& Max Limits apply for T_A between -40°C to $+85^{\circ}$C and T_J up to $+125^{\circ}$C for V_{IN} between 3.9 V to 7 V (Unless otherwise noted).} \\ \begin{tabular}{ll} \textbf{Typical values are referenced to $T_A = +25^{\circ}$C and $V_{IN} = 5$ V (Unless otherwise noted).} \\ \end{tabular}$

Symbol	Parameter	Conditions		Min	Тур	Max	Unit
JUNCTION	THERMAL MANAGEMENT						
T _{SD}	Thermal shutdown		Rising	125	140	150	°C
			Falling		115		°C
T _{H2}	Hot temp threshold 2		Relative to T _{SD}		-7		°C
T _{H1}	Hot temp threshold 1		Relative to T _{SD}		-11		°C
T _{WARN}	Thermal warning		Relative to T _{SD}		-15		°C
BUCK CO	NVERTER				•		
F _{SWCHG}	Switching Frequency			_	1.5	_	MHz
	Switching Frequency Accuracy			-10		+10	%
T _{DTYC}	Max Duty Cycle		Average		99.5		%
I _{PKMAX}	Maximum peak inductor current				3		Α
R _{ONLS}	Low side Buck MOSFET R _{DSON} (Q3)	Measured betw	een PGND and SW, V _{IN} = 5 V	-	70	110	mΩ
R _{ONHS}	High side Buck MOSFET R _{DSON} (Q2)	Measured betw	veen CAP and SW, V _{IN} = 5 V	-	55	85	mΩ
PROTECTI	ED TRANSCEIVER SUPPLY						
V _{TRANS}	Voltage on TRANS pin		$V_{IN} \ge 5 \text{ V}$		5	5.5	V
I _{TRMAX}	TRANS current capability			50			mA
I _{TROCP}	Short circuit protection					150	mA
TIMING					•		
T _{WD}	Watchdog timer				32		S
T _{USB}	USB timer				2048		s
T _{CHG1}	Charge timer		r pre-charge or weak-safe or ak-charge state.		3		h
T _{CHG2}	1		CC state		1		h
		CV state	TIMER_SEL = 0 (default)		2		h
			TIMER_SEL = 1		1		h
T _{WU}	Wake-up timer		<u> </u>		64		s
T _{ST}	Charger state timer,	From Weak-0	Charge to Full-Charge State		32		s
	Minimum transition time from states to states	From wait-sta	ate to safe-charge and from -wait to weak-safe		127		ms
			All others state		16		ms
T _{VRCHR}	Deglitch time for end of charge		V _{BAT} rising		15		ms
	voltage detection		V _{BAT} falling		127		ms
T _{INDET}	Deglitch time for input voltage detection	V _{IN} rising			15		ms
T _{DGS1}	Deglitch time for signal crossing I _{EOC} , V _{PRE} , V _{SAFE} , V _{CHGDET} thresholds	Rising and falling edge			15		ms
T _{DGS2}	Deglitch time for signal crossing V _{FET} , V _{BUSUV} , V _{BUSOV} thresholds	Risi	ng and falling edge		1		ms

 $\begin{tabular}{ll} \textbf{Table 4. ELECTRICAL CHARACTERISTICS} \\ \textbf{Min \& Max Limits apply for T_A between -40°C to $+85^{\circ}$C and T_J up to $+125^{\circ}$C for V_{IN} between 3.9 V to 7 V (Unless otherwise noted).} \\ \textbf{Typical values are referenced to $T_A = +25^{\circ}$C and $V_{IN} = 5$ V (Unless otherwise noted).} \\ \end{tabular}$

Symbol	Parameter		Conditions	Min	Тур	Max	Unit
BOOST CO	NVERTER AND OTG MODE						
V _{IBSTL}	Boost minimum input	E	Boost start-up	3.1	3.2	3.3	V
	operating range		Boost running	2.9	3	3.1	V
V _{IBSTH}	Boost maximum input operating range			4.4	4.5	4.6	V
V _{OBST}	Boost Output Voltage	DC value mea	asured on CAP pin, no load	5.00	5.1	5.15	V
V _{OBSTAC}	Boost Output Voltage accuracy	Measured on CA	AP pin Including line and load regulation	-3		3	%
I _{BSTMX}	Output current capability	Co	onfigured Mode	1000			mA
		Un-	configured Mode	150			mA
F _{SWBST}	Switching Frequency			1.35	1.5	1.65	MHz
I _{BPKM}	Maximum peak inductor current				3		Α
V _{OBSTOL1}	Boost overload	Voltage	e on CAP pin, falling	4.5	4.6	4.65	V
V _{OBSTOL2}		Un-configured M	lode, falling, Voltage on IN pin	4.3	4.4	4.5	
T _{OBSTOL}	Boost start-up time	From OTG	enable to VIN > V _{OBSTOL}			32	ms
I _{BSTPRE}	Boost Pre-charge current		l Mode, Measured on IN pin 29 Ω, CLOAD = 10 μF			350	mA
			Mode, Measured on IN pin 5.1 Ω, CLOAD = 10 μF			1.1	Α
T _{BSTPRE}	Boost Rise time	Configured Mode, Measured on	RLOAD = ∞, CLOAD = 1 μF	0.3		4	ms
		VIN, VIN rising (see Figure 3)	RLOAD = 5.1 Ω , CLOAD = 10 μ F				
V _{OBSTOV}	Overvoltage protection		V _{IN} rising	5.55	5.65	5.75	V
			Hysteresis			125	mV

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.



BLOCK DIAGRAM

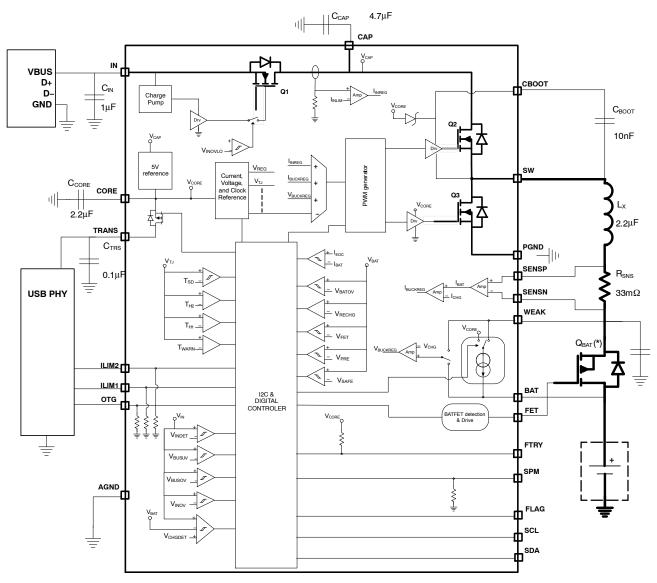
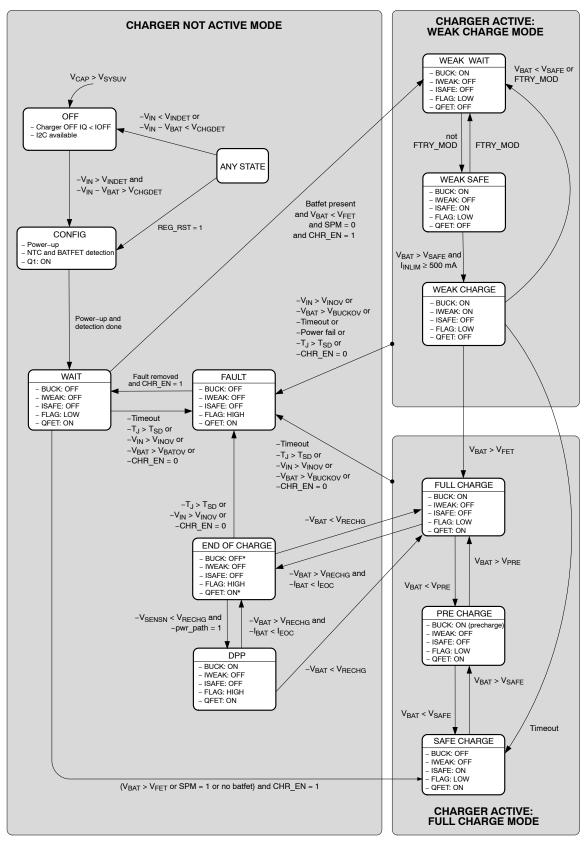


Figure 4. Block Diagram

CHARGING PROCESS



(*) see Power Path Management section

Figure 5. Detailed Charging Process

TYPICAL CHARACTERISTICS

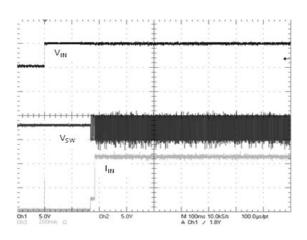


Figure 6. V_{BUS} Insertion

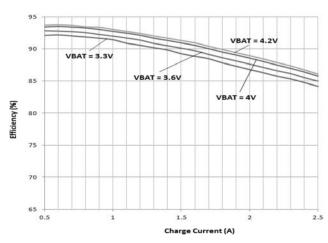


Figure 7. Charger Mode Efficiency

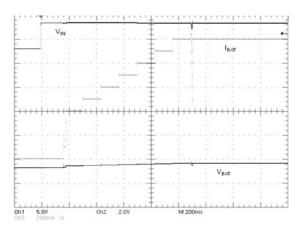


Figure 8. Automatic Charge Current

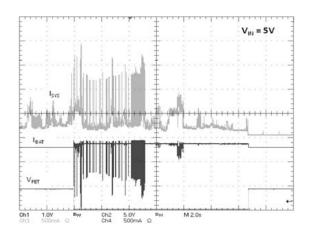


Figure 9. Dynamic Power Path

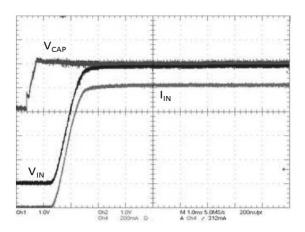


Figure 10. Boost Mode: Power-Up

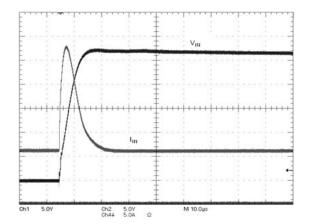


Figure 11. Over Voltage Protection

CHARGE MODE OPERATION

Overview

The NCP1854 is a fully programmable single cell Lithium-ion switching battery charger optimized for charging from a USB compliant input supply. The device integrates a synchronous PWM controller; power MOSFETs, and monitoring the entire charge cycle including safety features under software supervision. An optional battery FET can be placed between the system and the battery in order to isolate and supply the system in case of weak battery. The NCP1854 junction temperature and battery temperature are monitored during charge cycle and current and voltage can be modified accordingly through I²C setting. The charger activity and status are reported through a dedicated pin to the system. The input pin is protected against overvoltages.

The NCP1854 is fully programmable through I^2C interface (see Registers Map section for more details). All registers can be programmed by the system controller at any time during the charge process. The charge current (I_{CHG}), charge voltage (V_{CHG}), and input current (I_{INLIM}) are controlled by a dynamic voltage and current scaling for disturbance reduction. Is typically 10 μ s for each step.

NCP1854 also provides USB OTG support by boosting the battery voltage as well as an over voltage protected power supply for USB transceiver.

Charge Profile

In case of application without Q_{FET}, the NCP1854 provides 4 main charging phases as described below. Unexpected behaviour or limitations that can modify the charge sequence are described further (see Charging Process section).

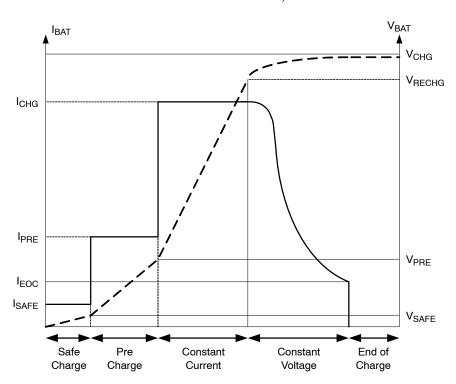


Figure 12. Typical Charging Profile of NCP1854

Safe Charge:

With a disconnected battery or completely empty battery, the charge process is in *safe charge* state, the charge current is set to I_{SAFE} in order to charge up the system's capacitors or the battery. When the battery voltage reaches V_{SAFE} threshold, the battery enters in pre-conditioning.

Pre Conditioning (pre-charge):

In preconditioning (pre *charge* state), the DC-DC convertor is enabled and an I_{PRE} current is delivered to the battery. This current is much lower than the full charge

current. The battery stays in preconditioning until the V_{BAT} voltage is lower than V_{PRE} threshold.

Constant Current (full charge):

In the constant current phase (full charge state), the DC–DC convertor is enabled and an I_{CHG} current is delivered to the load. As battery voltage could be sufficient, the system may be awake and sink an amount of current. In this case the charger output load is composed of the battery and the system. Thus I_{CHG} current delivered by the NCP1854 is shared between the battery and the system: $I_{CHG} = I_{SYS} + I_{BAT}$.

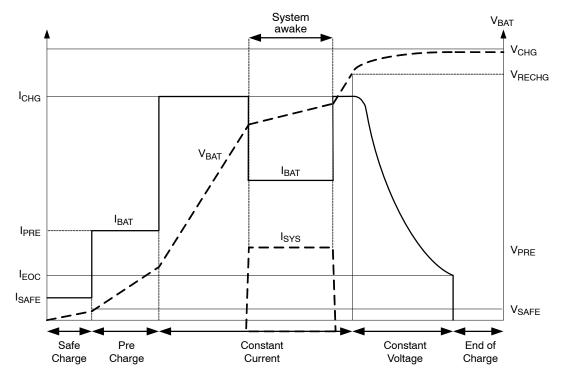


Figure 13. Typical Charging Profile of NCP1854 with System Awake

I_{CHG} current is programmable using I2C interface (register IBAT_SET – bits ICHG[3:0] and ICHG_HIGH). <u>Constant Voltage (full charge):</u>

The constant voltage phase is also a part of the *full charge* state. When the battery voltage is close to its maximum (V_{CHG}), the charge circuit will transition from a constant current to a constant voltage mode where the charge current will slowly decrease (taper off). The battery is now voltage controlled. V_{CHG} voltage is programmable using I2C interface (register VBAT SET– bits CTRL VBAT[5:0]).

End of Charge:

The charge is completed (end of charge state) when the battery is above the V_{RECHG} threshold and the charge current below the I_{EOC} level. The battery is considered fully charged and the battery charge is halted. Charging is resumed in the constant current phase when the battery voltage drops below the V_{RECHG} threshold. I_{EOC} current is programmable using I2C interface (register IBAT SET– bits IEOC[2:0]).

Power Stage Control

NCP1854 provides a fully-integrated 1.5 MHz step-down DC-DC converter for high efficiency. For an optimized charge control, 3 feedback signals control the PWM duty cycle. These 3 loops are: maximum input current (I_{INLIM}), maximum charge current (I_{CHG}) and, maximum charge voltage (V_{CHG}). The switcher is regulated by the first loop that reaches its corresponding threshold. Typically during charge current phase ($V_{PRE} < V_{BAT} < V_{RECHG}$), the measured input current and output voltage are below the programmed limit and asking for more power. But in the same time, the measured output current is at the programmed limit and thus regulates the DC-DC converter.

In order to prevent battery discharge and overvoltage protection, Q1 (reverse voltage protection) and Q2 (high side N-MOSFET of the DC-DC converter) are mounted in a back-to-back common drain structure while Q3 is the low side N MOSFET of the DC-DC converter. Q2 gate driver circuitry required an external bootstrap capacitor connected between CBOOT pin and SW pin.

An internal current sense monitors and limits the maximum allowable current in the inductor to I_{PEAK} value.

Charger Detection, Start-up Sequence and System Off

The start-up sequence begins upon an adaptor valid voltage plug in detection: $V_{IN} > V_{INDET}$ and $V_{IN} - V_{BAT} > V_{CHGDET}$ (off state).

Then, the internal circuitry is powered up and the presence of BATFET is reported (register STATUS – bit BATFET). When the power–up sequence is done, the charge cycle is automatically launched. At any time and any state, the user can hold the charge process and transit to *fault* state by setting CHG_EN to '0' (register CTRL1) in the I²C register. The I2C registers are accessible without valid voltage on V_{IN} if $V_{CAP} > V_{SYSUV}$ (i.e. if V_{BAT} is higher than V_{SYSUV} + voltage drop across Q2 body diode).

At any time, the user can reset all register stacks (register CTRL1 – bit REG_RST).

Weak Battery Support

An optional battery FET (Q_{BAT}) can be placed between the application and the battery. In this way, the battery can be isolated from the application and so-called weak battery operation is supported. Typically, when the battery is fully discharged, also referred to as weak battery, its voltage is not sufficient to supply the application. When applying a charger, the battery first has to be pre-charged to a certain level before operation. During this time; the application is supplied by the DC-DC converter while integrated current sources will pre-charge the battery to the sufficient level before reconnecting.

The pin FET can drive a PMOS switch (Q_{BAT}) connected between BAT and WEAK pin. It is controlled by the charger state machine (*Charging process* section). The basic behaviour of the FET pin is that it is always low. Thus the PMOS is conducting, except when the battery is too much discharged at the time a charger is inserted under the condition where the application is not powered on. The FET pin is always low for BAT above the V_{FET} threshold. Some exceptions exist which are described in the Charging process and *Power Path Management* section. The V_{FET} threshold is programmable (register MISC_SET – bit CTRL_VFET).

Batfet detection

The presence of a PMOS (Q_{BAT}) at the FET pin is verified by the charging process during its config state. To distinguish the two types of applications, in case of no battery FET the pin FET is to be tied to ground. In the config state an attempt will be made to raise the FET pin voltage slightly up to a detection threshold. If this is successful it is considered that a battery FET is present. The batfet detection is completed for the whole charge cycle and will be done again upon unplug condition ($V_{BAT} < V_{INDET}$ or $V_{IN} - V_{BAT} < V_{CHGDET}$) or register reset (register CTRL1– bit REG_RST).

Weak wait

Weak wait state is entered from wait state (see Charging process section) in case of BATFET present, battery voltage lower than V_{FET} and host system in shutdown mode (SPM = 0). The DCDC converter from VIN to SW is enabled and set to V_{CHG} while the battery FET Q_{BAT} is opened. The system is now powered by the DC–DC. The internal current source to the battery is disabled.

Weak safe

The voltage at V_{BAT} , is below the V_{SAFE} threshold. In weak safe state, the battery is charged with a linear current source at a current of I_{SAFE} . The DC-DC converter is enabled and set to V_{CHG} while the battery FET Q_{BAT} is opened. In case the ILIM pin is not made high or the input current limit defeated by I^2C before timer expiration, the state is left for the safe charge state after a certain amount of time (see Wake up Timer section). Otherwise, the state machine will transition to the weak charge state once the battery is above V_{SAFE} .

Weak charge

The voltage at V_{BAT} , is above the V_{SAFE} threshold. The DC-DC converter is enabled and set to V_{CHG} . The battery is initially charged at a charge current of I_{WEAK} supplied by a linear current source from WEAK pin (i.e. DC-DC converter) to BAT pin. I_{WEAK} value is programmable (register MISC_SET bits IWEAK). The weak charge timer (see *Wake up Timer* section) is no longer running. When the battery is above the V_{FET} threshold (programmable), the state machine transitions to the *full charge* state thus BATFET Q_{BAT} is closed.

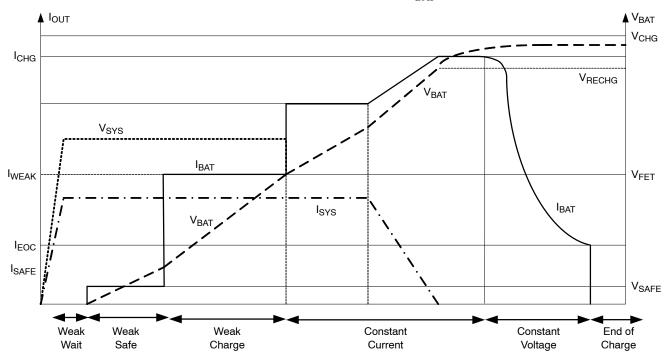


Figure 14. Weak Charge Profile

Weak Charge Exit

In some application cases, the system may not be able to start in *weak charge states* due to current capability limitation or/and configuration of the system. If so, in order to avoid unexpected "drop and retry" sequence of the buck output, the charge state machine allows only 3 system power—up sequences based on SPM pin level: If SPM pin level is toggled 3 times during *weak charge* states, the system goes directly to *safe charge* state and a *full charge mode* sequence is initiated ("Power fail" condition in Charging process section).

Power Path Management

Power path management can be supported when a battery FET (Q_{BAT}) is placed between the application and the battery. When the battery is fully charged (end of charge state), power path management disconnects the battery from the system by opening Q_{BAT} , while the DC-DC remains active. This will keep the battery in a fully charged state with the system being supplied from the DC-DC. If a load transient appears exceeding the DC-DC output current and thus causing V_{SENSEN} to fall below V_{RECHG} , the FET Q_{BAT} is instantaneously closed to reconnect the battery in order to provide enough current to the application. The FET Q_{BAT} remains closed until the end of charge state conditions are reached again. The power path management function is enabled through the I^2C interface (register CRTL2 bit PWR_PATH=1).

Safety Timer Description

The safety timer ensures proper and safe operation during charge process. The set and reset condition of the different safety timer (Watchdog timer, Charge timer, Wakeup timer and USB timer) are detailed below. When a timer expires (condition "timeout" in Charging process section), the charge process is halted.

Watchdog Timer

Watchdog timer ensures software remains alive once it has programmed the IC. The watchdog timer is no longer running since I²C interface is not available. Upon an I²C write, automatically a watchdog timer T_{WD} is started. The watchdog timer is running during *charger active* states and *fault* state. Another I²C write will reset the watchdog timer. When the watchdog times out, the state machine reverts to *fault* state and reported through I²C interface (register CHINT2–bit WDTO). Also used to time out the *fault* state. This timer can be disabled (Register CTRL2 bit WDTO DIS).

Charge Timer

A charge timer T_{CHG} is running that will make that the overall charge to the battery will not exceed a certain amount of energy. The charge timer is running during *charger active* states and halted during *charger not active* states (see *Charging process* section). The timer can also be cleared any time through I²C (register CTRL1 – bit TCHG_RST). The state machine transitions to *fault* state when the timer expires. This timer can be disabled (Register CTRL2 bit CHGTO DIS).

USB Timer

A USB charge timer $T_{\rm USB}$ is running in the *charger active* states while halted in the *charger non active* states. The timer keeps running as long as the lowest input current limit remains selected either by ILIM pin or I²C (register I_SET – bit IINLIM and IINLIM_EN and register IINLIM_SET bits IINLIM_TA). This will avoid exceeding the maximum allowed USB charge time for un–configured connections. When expiring, the state machine will transition to *fault* state. The timer is cleared in the *off* state or by I²C command (register CTRL1 – bit TCHG_RST).

Wake up Timer

Before entering weak charge state, NCP1854 verifies if the input current available is enough to supply both the application and the charge of the battery. A wake-up timer T_{WU} verifies if ILIM pin is raised fast enough or application powered up (by monitoring register I_SET – bit IINLIM and IINLIM_EN and register IINLIM_SET bits IINLIM_TA) after a USB attachment. The wake up timer is running in weak wait state and weak safe state and clears when the input current limit is higher than 100 mA.

Input Current Limitation

In order to be USB specification compliant, the input current at V_{IN} is monitored and could be limited to the I_{INLIM} threshold. The input current limit threshold is selectable through the ILIMx pin. When low, the one unit USB current is selected ($I_{IN} \leq 100$ mA), where when made high 5 units are selected ($I_{IN} \leq 500$ mA). In addition, this current limit can be programmed through I^2C (register MISC_SET bits IINLIM and register IINLIM_SET bits IINLIM_TA) therefore defeating the state of the ILIMx pin. In case of non-limited input source, current limit can be disabled (register CTRL2 bit IINLIM_EN). The current limit is also disabled in case the input voltage exceeds the V_{BUSOV} threshold.

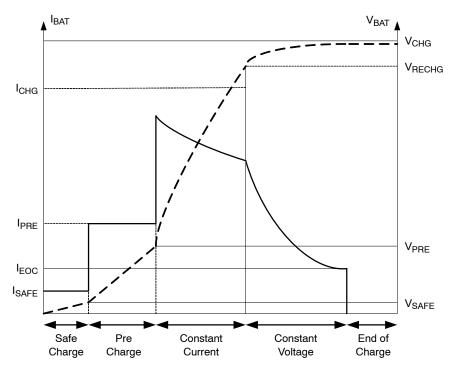


Figure 15. Typical Charging Profile of NCP1854 with Input Current Limit

Input Voltage Based Automatic Charge Current

If the input power source capability is unknown, automatic charge current will automatically increase the charge current step by step until the V_{IN} drops to V_{BUSUV} . Upon V_{BUSUV} being triggered, the charge current I_{CHG} is immediately reduced by 1 step and stays constant until V_{IN} drops again to V_{BUSUV} . The ICHG current is clamped to the I^2C register value (register IBAT_SET, bits ICHG). This unique feature is enabled when the pins ILIM1 = 0 and ILIM2 = 1 or through I^2C register (register CRTL2 bit AICL_EN).

ILIM1	ILIM2	Input Current Limit				
0	0	100 mA				
0	1	Automatic Charge Current				
1	0	500 mA				
1	1	900 mA				

Junction Temperature Management

During the charge process, NCP1854 monitors the temperature of the chip. If this temperature increases to T_{WARN} , an interrupt request (described in section Charge status reporting) is generated and bit TWARN_SNS is set to '1' (register TEMP_SENSE). Knowing this, the user is free to halt the charge (register CTRL – bit CHG_EN) or reduce the charge current (register I_SET – bits ICHG). When chip temperature reaches T_{SD} value, the charge process is automatically halted.

Between T_{WARN} and T_{SD} threshold, a junction temperature management option is available by setting 1 to TJ_WARN_OPT bit (register CONTROL). In this case, if the die temperature hits T_{M1} threshold, an interrupt is generated again but NCP1854 will also reduce the charge current I_{CHG} by two steps or 200 mA. This should in most cases stabilize the die temperature because the power dissipation will be reduced by approximately 50 mW. If the die temperature increases further to hit T_{M2}, an interrupt is generated and the charge current is reduced to its lowest level or 400 mA. The initial charge current will be re–established when the die temperature falls below the T_{WARN} again.

If bit TJ_WARN_OPT = 0 (register CTRL1), the charge current is not automatically reduced, no current changes actions are taken by the chip until T_{SD}.

Regulated Power Supply (Trans pin)

NCP1854 has embedded a linear voltage regulator (V_{TRANS}) able to supply up to I_{TRMAX} to external loads. This output can be used to power USB transceiver. Trans pin is enabled if a V_{BUS} valid is connected on input pin ($V_{BUSUV} < V_{IN} < V_{BUSOV}$) and can be disabled through I^2C (bit TRANS_EN_REG register CTRL2).

Charge Status Reporting

FLAG pin

FLAG pin is to used to report charge status to the system processor and for interruption request.

During *charger active* states and *wait* state, the pin FLAG is low in order to indicate that the charge of the battery is in progress. When charge is completed or disabled or a fault occurs, the FLAG pin is high as the charge is halted.

STATUS and CONTROL Registers

The status register contains the current charge state, BATFET connection as well as fault and status interrupt (bits FAULTINT and STATINT in register STATUS). The charge state (bits STATE in register STATUS) is updated on the fly and corresponds to the charging state described in Charging process section. An interruption (see description below) is generated upon a state change. In the *config* state, hardware detection is performed on BAFTET pins. From wait state, their statuses are available (bit BATFET in register STATUS). STATINT bit is set to 1 if an interruption appears on STAT_INT register (see description below). FAULTINT bit is set to 1 if an interruption appears on registers CH1 INT, CH1 INT or BST INT. Thanks to this register, the system controller knows the chip status with only one I²C read operation. If a fault appears or a status change (STATINT bits and FAULTINT), the controller can read corresponding registers for more details.

Interruption

Upon a state or status change, the system controller is informed by sensing FLAG pin. A T_{FLAGON} pulse is generated on this pin in order to signalize an event. The level of this pulse depends on the state of the charger (see *Charging process* section):

- When charger is in charger active states and wait state the FLAG is low and consequently the pulse level on FLAG pin is high.
- In the other states, the pulse level is low as the FLAG stable level is high.

Charge state transition even and all bits of register STAT_INT, CH1_INT, CH2_INT, BST_INT generate an interrupt request on FLAG pin and can be masked with the corresponding mask bits in registers STAT_MSK, CH1_MSK, CH2_MSK and BST_MSK. All interrupt signals can be masked with the global interrupt mask bit (bit INT_MASK register CTRL1). All these bits are read to clear. The register map (see REGISTERS MAP section) indicated the active transition of each bits (column "TYPE" in see REGISTERS MAP section).

If more than 1 interrupt appears, only 1 pulse is generated while interrupt registers (STAT_INT, CH1_INT, CH2_INT, BST_INT) will not fully clear.

Sense and Status Registers

At any time the system processor can know the status of all the comparators inside the chip by reading VIN_SNS, VBAT_SNS, and TEMP_SNS registers (read only). These bits give to the system controller the real time values of all the corresponding comparators outputs (see BLOCK DIAGRAM).

Battery Removal

During normal charge operation the battery may bounce or be removed. The state transition of the state machine only occurs upon deglitched signals which allow bridging any battery bounce. True battery removal will last longer than the debounce times. The NCP1854 handles battery removal if a BATFET is present and power path option is enable (register CRTL2 bit PWR PATH=1)

If the battery removal appears during the charge cycle, the NCP1854 will behave normally and charge up very quickly the equivalent capacitor seen on VSENSN and/or VBAT (from tens to hundreds of milliseconds). The state machine will automatically end up in *end of charge / dpp* state while the DCDC is still enabled and the system still supplied.

Factory Mode and No Battery Operation

During factory testing no battery is present in the application and a supply could be applied through the bottom connector to power the application. The state machine will support this mode of operation if a BATFET is present and if the application processor can configure NCP1854 within 32 seconds. In factory mode condition, the NCP1854 is locked in weak wait state (DCDC enable and no weak charge). The factory mode is enabled through the FTRY pin or through I²C (Register CTRL1 Bit FCTRY_MOD_REG) according to the following logic table.

FTRY Pin	FCTRY_MOD_REG	FTRY_MODE (Factory mode)
0	0	Enable
0	1	Disable
1	0	Disable
1	1	Enable

Remark: The charge current loop (ICHG) and input current loop are disabled in factory mode so full power is available for the system.

Through I²C the device is entirely programmable so the controller can configure appropriate current and voltage threshold for handle factory testing.

BOOST MODE OPERATION

The DC–DC Converter can also be operated in a Boost mode where the application voltage is stepped up to the input V_{IN} for USB OTG supply. The converter operates in a 1.5 MHz fixed frequency PWM mode or in pulse skipping mode under low load condition. In this mode, where CAP is the regulated output voltage, Q3 is the main switch and Q2 is the synchronous rectifier switch. While the boost converter is running, the Q1 MOSFET is conducting.

Boost Start-up Sequence

The boost mode is enabled through the OTG pin or I^2C (register CTRL1 – bit OTG_EN). Upon a turn on request, the converter regulates CAP pin to V_{OBST} by smoothly boost up (DVS) the battery voltage while Q1 MOSFET is maintained open. The rest of the startup sequence depends on the accessory configuration:

• Un-Configured USB port (USB CFG = 0)

According to USB Spec, the maximum load that can be placed at the downstream end of a cable is 10 μF in parallel with 29 Ω . In that case, the I_{BSTPRE} current source will precharge the IN pin to the operating voltage.

• Configured USB port (USB_CFG = 1)

A configured USB OTG port should be able to provide 5 units (650 mA DC). End user can program the NCP1854 to provide the maximum current during start up in case of specific USB dual role application (register CTRL1 – bit USB_CFG). A soft start circuitry of Q1 MOSFET will control the inrush current

Boost Running

When running, user can change from Un-configured to configured mode on the fly and vise versa thanks to USB_CFG bit.

Boost Over-Voltage Protection

The NCP1854 contains integrated over-voltage protection on the $V_{\rm IN}$ line. During boost operation ($V_{\rm IN}$ supplied), if an over-voltage condition is detected ($V_{\rm IN}$ > $V_{\rm OBSTOV}$), the controller turns off the PWM converter and a fault is indicated to the system controller (bit VBUSOV register BST_INT).

Boost Over-Current Protection

The NCP1854 contains over current protection to prevent the device and battery damage when V_{IN} is overloaded. When the CAP voltage drops down to $V_{OBSTOL1}$, NCP1854 determine an over–current condition is met, so Q1 MOSFET and PWM converter are turned off. A fault is indicated to the system controller (bit $V_{OBSTOL1}$ register BST INT).

Boost Over-Load Indication (Un-configured mode)

In un-configured mode, the load on IN can exceed I_{BSTPRE} . In that case, the system indicated to the user (bit $V_{OBSTOL2}$ register BST_INT) that a more than 1 unit load is connected to the NCP1854.

This indicator can also be used to detect a device attached upon a hot plug on VIN.

Battery Out of Range Protection

During boost mode, when the battery voltage is lower than the battery under voltage threshold ($V_{BAT} < V_{IBSTL}$), or higher than the overvoltage threshold ($V_{BAT} > V_{IBSTH}$), the IC turns off the PWM converter. A fault is indicated to the system controller (bit VBAT NOK register BST INT)

A toggle on OTG pin or OTG_EN bit (register CTRL1) is needed to start again a boost operation.

Boost Status Reporting

STATUS and CTRL Registers

The status register contains the boost status. Bits STATE in register STATUS gives the boost state to the system controller. Bits FAULTINT and STATINT in register STATUS are also available in boost mode. If a fault appears or a status changes (STATINT bits and FAULTINT) the processor can read corresponding registers for more details.

Interruption

In boost mode, valid interrupt registers are STAT_INT and BST_INT while CH1_INT and CH2_INT are tied to their reset value. Upon a state or status changes, the system controller is informed by sensing FLAG pin. Like in charge mode, T_{FLAGON} pulse is generated on this pin in order to signalize the event. The pulse level is low as the FLAG level is high in boost mode. Charge state transition even and all signals of register BST_INT can generate an interrupt request on FLAG pin and can be masked with the corresponding mask bits in register BST_MSK. All these bits are read to clear. The register map (see Registers Map section) indicates the active transition of each bits (column "TYPE" in see Registers Map section). If more than 1 interrupt appears, only 1 pulse is generated while interrupt registers (listed just above) will not fully clear.

Sense and Status Registers

At any time the system controller can know the status of all the comparator inside the chip by reading VIN_SNS and TEMP_SNS registers (read only). These bits give to the controller the real time values of all the corresponding comparators outputs (see Block Diagram).

Table 5. REGISTERS MAP

Table	5. REGISTE	K9 MAP	<u> </u>		
Bit	Туре	Reset	Name	RST Value	Function
STATU	IS REGISTER	- Memory location : 00			
7–4	R	No_Reset	STATE[3:0]	0000	Charge mode: -0000 : OFF -0001 : WAIT + STBY -0010 : SAFE CHARGE -0011 : PRE CHARGE -0100 : FULL CHARGE -0101 : VOLTAGE CHARGE -0110 : CHARGE DONE -0111 : DPP -1000 : WEAK WAIT -1001 : WEAK SAFE -1010 : WEAK CHARGE -1011 : FAULT Boost mode: -1100 : OTG SET UP -1101 : OTG CONFIGURED -1111 : OTG FAULT
3	R	No_Reset	BATFET	0	Indicate if a batfet is connected: 0 : No BATFET is connected 1 : BATFET is connected.
2	R	No_Reset	RESERVED	0	
1	R	No_Reset	STATINT	0	Status interrupt: 0 : No status interrupt 1 : Interruption flagged on STAT_INT register
0	R	No_Reset	FAULTINT	0	Fault interrupt: 0 : No status interrupt 1 : interruption flagged on CHRIN1, CHRIN2 or BST_INT register
CTRL	REGISTER -	- Memory location : 01			
7	RW	OFF STATE, POR, REG_RST	REG_RST	0	Reset: 0 : No reset 1 : Reset all registers
6	RW	OFF STATE, POR, REG_RST	CHG_EN	1	Charge control: 0 : Halt charging (go to fault state) or OTG operation 1 : Charge enabled / Charge resume
5	RW	OFF STATE, POR, REG_RST, CHGMODE	OTG_EN	0	On the go enable: 0 : no OTG operation 1 : OTG operation (set by I2C or OTG pin)
4	RW	OFF STATE, POR, REG_RST, OTGMODE	FCTRY_MOD_REG	1	Factory mode (See Section Factory mode and No battery operation)
3	RW	OFF STATE, POR, REG_RST	TJ_WARN_OPT	0	Enable charge current vs Junction temperature 0: No current change versus junction temperature 1: Charge current is reduced when TJ is too high.
2	R	OFF STATE, POR, REG_RST	USB_CFG	1	0 : OCP between CAP and IN after boost start up done 1 : R _{RBFET} between CAP and IN after boost start up done
1	RW	OFF STATE, POR, REG_RST, TRM_RST	TCHG_RST	0	Charge timer reset: 0 : no reset 1 : Reset and resume charge timer(tchg timer) (self clearing)
0	RW	OFF STATE, POR, REG_RST	INT_MASK	1	global interrupt mask 0 : All Interrupts can be active. 1 : All interrupts are not active

Table 5. REGISTERS MAP

Table	5. REGISTE	RS MAP									
Bit	Туре	Reset	Name	RST Value	Function						
CTRL	CTRL2 REGISTER - Memory location : 02										
7	RW	OFF STATE, POR, REG_RST, OTGMODE	WDTO_DIS	0	Disable watchdog timer 0: Watchdog timer enable 1: Watchdog timer disable						
6	RW	OFF STATE, POR, REG_RST, OTGMODE	CHGTO_DIS	0	Disable charge timer 0: Charge timer enable 1: Charge timer disable						
5	RW	OFF STATE, POR, REG_RST, OTGMODE	PWR_PATH	0	Power Path Management: 0: Power Path disable 1: Power Path enable						
4	RW	OFF STATE, POR, REG_RST	TRANS_EN_REG	1	Trans pin operation enable: 0 : Trans pin is still off 1 : Trans pin is supply						
3	R				Reserved						
2	RW	OFF STATE, POR, REG_RST, OTGMODE	IINSET_PIN_EN	1	Enable input current set pin: 0: Input current limit and AICL control by I ² C 1: Input current limit and AICL control by pins ILIMx						
1	RW	OFF STATE, POR, REG_RST, OTGMODE	IINLIM_EN	1	Enable input current limit: 0: No input current limit 1: Input current limit is IINLIM[3:0]						
0	RW	OFF STATE, POR, REG_RST, OTGMODE	AICL_EN	0	Enable automatic charge current: 0: No AICL 1: AICL						
STAT	INT REGISTI	ER - Memory location : 03									
7–6	R	No_Reset	RESERVED								
5	RCDual	OFF STATE, POR, REG_RST	TWARN	0	0 : Silicon temperature is below TWARN threshold 1 : Silicon temperature is above TWARN threshold						
4	RCDual	OFF STATE, POR, REG_RST	TM1	0	0 : Silicon temperature is below T1 threshold 1 : Silicon temperature is above T1 threshold						
3	RCDual	OFF STATE, POR, REG_RST	TM2	0	0 : Silicon temperature is below T2 threshold 1 : Silicon temperature is above T2 threshold						
2	RCDual	OFF STATE, POR, REG_RST	TSD	0	0 : Silicon temperature is below TSD threshold 1 : Silicon temperature is above TSD threshold						
1	R	No_Reset	RESERVED	0							
0	RCDual	OFF STATE, REG_RST, POR, OTGMODE	VBUSOK	0	0: charger not in USB range 1: charger in USB charging range VBUSUV < VIN < VBUSOV						
CH1_I	NT REGISTE	R - Memory location : 04									
7–5	R	No_Reset	RESERVED	0							
4	RCDual	OFF STATE, REG_RST, POR, OTGMODE	VINLO	0	VIN changer detection interrupt: 1: VIN - VBAT > VCHGDET and VIN < VINDET						
3	RCDual	OFF STATE, REG_RST, POR, OTGMODE	VINHI	0	VIN over voltage lock out interrupt: 1: VIN > VINOV						
2	R	No_Reset	RESERVED	0							
1	RCDual	OFF STATE, REG_RST, POR, OTGMODE	BUCKOVP	0	VBAT over voltage interrupt: 1: VBAT > VOVP						
0	R	No_Reset	CHINT2	0	charger related interrupt (CH2_INT register)						
-	-			•							

Table 5 REGISTERS MAP

Table	5. REGISTE	RS MAP								
Bit	Туре	Reset	Name	RST Value	Function					
CH2_INT REGISTER - Memory location : 05										
7	R	No_Reset	RESERVED	0						
6	R	No_Reset	RESERVED	0						
5	R	No_Reset	RESERVED	0						
4	R	No_Reset	RESERVED	0						
3	RCSingle	OFF STATE, POR, REG_RST, TRM_RST, OTGMODE	WDTO	0	watchdog timeout expires interrupt: 1: 32s timer expired.					
2	RCSingle	OFF STATE, POR, REG_RST, TRM_RST, OTGMODE	USBTO	0	usb timeout expires interrupt: 1: 2048s timer expired					
1	RCSingle	OFF STATE, POR, REG_RST, TRM_RST, OTGMODE	CHGTO	0	charge timeout expires interrupt: 1: 3600s timer expired					
0	R	No_Reset	CHINT1	0	charger related interrupt (CH1_INT register)					
BST_I	NT REGISTE	R - Memory location : 06								
7–4	R	No_Reset	RESERVED	0000						
3	RCDual	OFF STATE, BOOST START UP STATE, POR, REG_RST, CHGMODE	VOBSTOL2	0	vbus overload interrupt: 1: Vbus voltage < V _{OBSTOL2}					
2	RCSingle	OFF STATE, POR, REG_RST, CHGMODE	VOBSTOL1	0	vbus overload interrupt: 1: VCAP voltage < V _{OBSTOL1}					
1	RCDual	OFF STATE, POR, REG_RST, CHGMODE	VBUSOV	0	vbus overvoltage interrupt: 1: Vbus voltage < VBUSOV					
0	RCDual	OFF STATE, POR, REG_RST, CHGMODE	VBAT_NOK	0	vbat out of range interrupt: 1: V _{IBSTH} < Vbat voltage < VIBSTL					
VIN_S	NS REGISTE	R – Memory location : 07								
7	R	No_Reset	VINOVLO_SNS	0	VIN over voltage lock out comparator 1: VIN > VINOV					
6	R	No_Reset	RESERVED	0						
5	R	No_Reset	VBUSOV_SNS	0	VIN not is USB range comparator 1: VIN > VBUSOV					
4	R	No_Reset	VBUSUV_SNS	0	VIN not is USB range comparator 1: VIN < VBUSUV					
3	R	No_Reset	VINDET_SNS	0	VIN voltage detection comparator 1: VIN > VINDET					
2	R	No_Reset	VCHGDET_SNS	0	VIN changer detection comparator 1: VIN - VBAT > VCHGDET					
1	R	No_Reset	VOBSTOL2_SNS	0	VIN OTG under voltage comparator 1: Vbus voltage < V _{OBSTOL2}					
0	R	No_Reset	RESERVED	0						

Table 5 REGISTERS MAP

Table	Table 5. REGISTERS MAP					
Bit	Туре	Reset	Name	RST Value	Function	
VBAT	VBAT_SNS REGISTER - Memory location : 08					
7	R	No_Reset	RESERVED	0		
6	R	No_Reset	VBAT_OV_SNS	0	VBAT over voltage comparator 1: VBAT > VOVP	
5	R	No_Reset	VRECHG_OK_SNS	0	VBAT recharge comparator 1: VBAT > VRECHG	
4	R	No_Reset	VFET_OK_SNS	0	VBAT weak charge comparator 1: VBAT > VFET	
3	R	No_Reset	VPRE_OK_SNS	0	VBAT precharge comparator 1: VBAT > VPRE	
2	R	No_Reset	VSAFE_OK_SNS	0	VBAT safe comparator 1: VBAT > VSAFE	
1	R	No_Reset	IEOC_OK_SNS	0	End of charge current comparator 1: ICHARGE > IEOC	
0	R	No_Reset	RESERVED	0		
TEMP	SNS REGIS	TER - Memory location : 0	9			
7	R	No_Reset	RESERVED	0		
6	R	No_Reset	RESERVED	0		
5	R	No_Reset	RESERVED	0		
4	R	No_Reset	RESERVED	0		
3	R	No_Reset	TSD_SNS	0	Chip thermal shut down comparator 1: Chip Temp > TSD	
2	R	No_Reset	TM2_SNS	0	Chip thermal shut down comparator 1: Chip Temp > tm2	
1	R	No_Reset	TM1_SNS	0	Chip thermal shut down comparator 1: Chip Temp > tm1	
0	R	No_Reset	TWARN	0	Chip thermal shut down comparator 1: Chip Temp > twarn	
STAT_	MSK REGIS	TER – Memory location : 0	Α			
7	R	No_Reset	RESERVED	0		
6	R	No_Reset	RESERVED	0		
5	RW	OFF STATE, POR, REG_RST	TWARN_MASK	0	TWARN interruption mask bit.	
4	RW	OFF STATE, POR, REG_RST	TM1_MASK	0	TM1 interruption mask bit.	
3	RW	OFF STATE, POR, REG_RST	TM2_MASK	0	TM2 interruption mask bit.	
2	RW	OFF STATE, POR, REG_RST	TSD_MASK	0	TSD interruption mask bit.	
1	R	No_Reset	RESERVED	0		
0	RW	OFF STATE, POR, REG_RST, OTGMODE	VBUSOK_MASK	0	VBUSOK interruption mask bit.	

Table 5 REGISTERS MAP

Table	Table 5. REGISTERS MAP					
Bit	Туре	Reset	Name	RST Value	Function	
CH1_N	MSK REGIST	ER - Memory location : 0E	3			
7–5	R	No_Reset	RESERVED	0		
4	RW	OFF STATE, POR, REG_RST, OTGMODE	VINLO_MASK	0	VINLO interruption mask bit.	
3	RW	OFF STATE, POR, REG_RST, OTGMODE	VINHI_MASK	0	VINHI interruption mask bit.	
2	R	No_Reset	RESERVED	0		
1	RW	OFF STATE, POR, REG_RST, OTGMODE	BUCKOVP_MASK	0	BUCKOVP interruption mask bit.	
0	RW	OFF STATE, POR, REG_RST, OTGMODE	STATECHG_MASK	0	State transition interruption mask bit.	
CH2_N	MSK REGIST	ER – Memory location : 00				
7–4	R	No_Reset	RESERVED	0000		
3	RW	OFF STATE, POR, REG_RST, OTGMODE	WDTO_MASK	1	WDTO interruption mask bit.	
2	RW	OFF STATE, POR, REG_RST, OTGMODE	USBTO_MASK	1	USBTO interruption mask bit.	
1	RW	OFF STATE, POR, REG_RST, OTGMODE	CHGTO_MASK	1	CHGTO interruption mask bit.	
0	R	No_Reset	RESERVED	0		
BST_N	MSK REGIST	ER – Memory location : 00)			
7–5	R	No_Reset	RESERVED	0		
4	RW	OFF STATE, POR, REG_RST, OTGMODE	VOBSTOL2_MASK	1		
3	RW	OFF STATE, POR, REG_RST, OTGMODE	VOBSTOL1_MASK	1		
2	RW	OFF STATE, POR, REG_RST, OTGMODE	VBUSOV_MASK	1		
1	RW	OFF STATE, POR, REG_RST, OTGMODE	VBAT_NOK_MASK	1		
0	RW	OFF STATE, POR, REG_RST, OTGMODE	STATEOTG_MASK	1	STATEOTG interruption mask bit.	
VBAT	SET REGIS	TER – Memory location : 0	E			
7–6	R	No_Reset	RESERVED	00		
5–0	RW	OFF STATE, POR, REG_RST, OTGMODE	CTRL_VBAT [5:0]	001100	000000: 3.3 V 001100: 3.6 V 110000: 4.5 V Step: 0.025 V	
IBAT_	IBAT_SET REGISTER - Memory location : 0F					
7	RW	OFF STATE, POR, REG_RST, OTGMODE	ICHG_HIGH	0	Output current MSB: 0, ICHG[] = ICHG 1, ICHG[] = 1.6A + ICHG	
6–4	RW	OFF STATE, POR, REG_RST, OTGMODE	IEOC[2:0]	010	000: 100 mA 010: 150 mA 111: 275 mA Step: 25 mA	
3–0	RW	OFF STATE, POR, REG_RST, OTGMODE	ICHG[3:0]	0110	Output range current programmable range: 0000: 450 mA 1111: 1.9 A Step: 100 mA	

Table 5. REGISTERS MAP

Bit	Туре	Reset	Name	RST Value	Function
		ER – Memory location : 10		<u> </u>	1 5.15.15.11
- WIIGO_	OLI IILGISI	En - Memory location : 10			
7	R				Reserved
6–5	RW	OFF STATE, POR, REG_RST, OTGMODE	IWEAK[1:0]	01	Charge current during weak battery states: 00: Disable 01: 100 mA 10: 200 mA 11: 300 mA
4–2	RW	OFF STATE, POR, REG_RST, OTGMODE	CTRL_VFET[2:0]	011	Battery to system re-connection threshold: 000: 3.1 V 001: 3.2 V 010: 3.3 V 011: 3.4 V 100: 3.5 V 101: 3.6 V
1-0	RW	OFF STATE, POR, REG_RST, OTGMODE	IINLIM[2:0]	00	Input current limit range: 00: 100 mA 01: 500 mA 10: 900 mA 11: 1500 mA
IINLIM_SET REGISTER - Memory location : 11					
7–4	RW	OFF STATE, POR, REG_RST, OTGMODE	IINLIM_TA[3:0]	0000	Input current limit range: 0000: IINLIM 0001: 600 mA 1111: 2000 mA Step: 100 mA

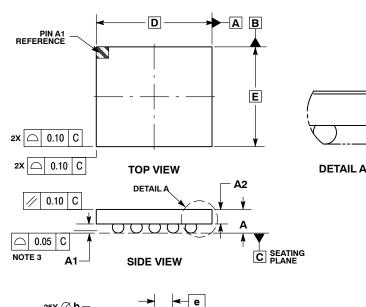
ORDERING INFORMATION

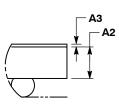
Device Order Number	I ² C address	Marking	Shipping [†]	
NCP1854FCCT1G	6C	1854	3000 / Tape & Reel	

[†]For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

PACKAGE DIMENSIONS

25 Pin Flip-Chip, 2.55x2.20 CASE 499BN **ISSUE A**



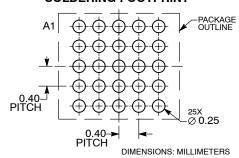


NOTES:

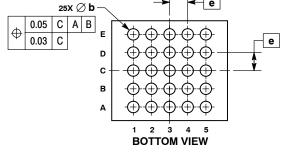
- DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 1994.
- CONTROLLING DIMENSION: MILLIMETERS. COPLANARITY APPLIES TO SPHERICAL CROWNS OF SOLDER BALLS.

	MILLIMETERS		
DIM	MIN	MAX	
Α		0.60	
A1	0.17	0.23	
A2	0.36 REF		
АЗ	0.04 REF		
b	0.24	0.29	
D	2.55 BSC		
Е	2.20 BSC		
е	0.40 BSC		

RECOMMENDED **SOLDERING FOOTPRINT***



*For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.



ON Semiconductor and war registered trademarks of Semiconductor Components Industries, LLC (SCILLC). SCILLC owns the rights to a number of patents, trademarks, copyrights, trade secrets, and other intellectual property. A listing of SCILLC's product/patent coverage may be accessed at www.onsemi.com/site/pdf/Patent-Marking.pdf. SCILLC reserves the right to make changes without further notice to any products herein. SCILLC makes no warranty, representation or guarantee regarding the suitability of its products for any particular purpose, nor does SCILLC assume any liability arising out of the application or use of any product or circuit, and specifically disclaims any and all liability, including without limitation special, consequential or incidental damages. "Typical" parameters which may be provided in SCILLC data sheets and/or specifications can and do vary in different applications and actual performance may vary over time. All operating parameters, including "Typicals" must be validated for each customer application by customer's technical experts. SCILLC does not convey any license under its patent rights nor the rights of others. SCILLC products are not designed, intended, or authorized for use as components in systems intended for surgical implications to be below or other applications. surgical implant into the body, or other applications intended to support or sustain life, or for any other application in which the failure of the SCILLC product could create a situation where personal injury or death may occur. Should Buyer purchase or use SCILLC products for any such unintended or unauthorized application, Buyer shall indemnify and hold SCILLC and its officers, employees, subsidiaries, affiliates, and distributors harmless against all claims, costs, damages, and expenses, and reasonable attorney fees arising out of, directly or indirectly, any claim of personal injury or death associated with such unintended or unauthorized use, even if such claim alleges that SCILLC was negligent regarding the design or manufacture of the part. SCILLC is an Equal Opportunity/Affirmative Action Employer. This literature is subject to all applicable copyright laws and is not for resale in any manner.

PUBLICATION ORDERING INFORMATION

LITERATURE FULFILLMENT:

Literature Distribution Center for ON Semiconductor P.O. Box 5163, Denver, Colorado 80217 USA

Phone: 303–675–2175 or 800–344–3860 Toll Free USA/Canada **Fax**: 303–675–2176 or 800–344–3867 Toll Free USA/Canada Email: orderlit@onsemi.com

N. American Technical Support: 800-282-9855 Toll Free USA/Canada

Europe, Middle East and Africa Technical Support: Phone: 421 33 790 2910

Japan Customer Focus Center Phone: 81-3-5817-1050

ON Semiconductor Website: www.onsemi.com

Order Literature: http://www.onsemi.com/orderlit

For additional information, please contact your local Sales Representative



Компания «ЭлектроПласт» предлагает заключение долгосрочных отношений при поставках импортных электронных компонентов на взаимовыгодных условиях!

Наши преимущества:

- Оперативные поставки широкого спектра электронных компонентов отечественного и импортного производства напрямую от производителей и с крупнейших мировых складов:
- Поставка более 17-ти миллионов наименований электронных компонентов;
- Поставка сложных, дефицитных, либо снятых с производства позиций;
- Оперативные сроки поставки под заказ (от 5 рабочих дней);
- Экспресс доставка в любую точку России;
- Техническая поддержка проекта, помощь в подборе аналогов, поставка прототипов;
- Система менеджмента качества сертифицирована по Международному стандарту ISO 9001:
- Лицензия ФСБ на осуществление работ с использованием сведений, составляющих государственную тайну;
- Поставка специализированных компонентов (Xilinx, Altera, Analog Devices, Intersil, Interpoint, Microsemi, Aeroflex, Peregrine, Syfer, Eurofarad, Texas Instrument, Miteq, Cobham, E2V, MA-COM, Hittite, Mini-Circuits, General Dynamics и др.);

Помимо этого, одним из направлений компании «ЭлектроПласт» является направление «Источники питания». Мы предлагаем Вам помощь Конструкторского отдела:

- Подбор оптимального решения, техническое обоснование при выборе компонента;
- Подбор аналогов;
- Консультации по применению компонента;
- Поставка образцов и прототипов;
- Техническая поддержка проекта;
- Защита от снятия компонента с производства.



Как с нами связаться

Телефон: 8 (812) 309 58 32 (многоканальный)

Факс: 8 (812) 320-02-42

Электронная почта: org@eplast1.ru

Адрес: 198099, г. Санкт-Петербург, ул. Калинина,

дом 2, корпус 4, литера А.